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Heterophase materials in ZrSi₂-ZrB₂-MoSi₂ system: synthesis, kinetics and mechanisms of high-temperature oxidation

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Abstract

This work presents the results of studying the kinetics and mechanism of high-temperature oxidation of compact heterophase ceramics in the ZrSi₂-MoSi₂-ZrB₂ system at temperatures of 1400 and 1650°C for 10 and 5 hours, respectively. Ceramics was obtained by hot pressing of composite powders made by the method of self-propagating high-temperature synthesis according to the scheme of magnesium thermal reduction. The kinetics of oxidation is described by a power law, which indicates a significant influence of evolutionary changes in the structure of the formed oxide films on the course of the process. The oxidation mechanism at 1400°C includes the formation of a two-layer structure consisting of a continuous silicate film, the outer part of which is saturated with magnesium, and a sublayer based on the ZrSiO₄ phase with a scheelite structure encapsulating ZrB₂ and MoSi₂ grains. The mechanism of oxidation at 1650°C includes the formation of secondary compounds MoB and Mo₅Si₃. The effect of the ZrSiO₄ phase, the formation of secondary compounds MoB and Mo₅Si₃. The effect of the ZrSi₂, MoSi₂ and ZrB₂ phases on the structural-morphological features of the forming oxide films and the effectiveness of their protective action is shown. In the ZrSi₂-ZrSiO₄ system above 1620°C, under conditions of lack or absence of oxygen, silicon is being recovered with simultaneous oxidation of zirconium to ZrO₂.

Keywords: *heterophase ceramics, self-propagating high-temperature synthesis, oxidation, kinetics, mechanism.*

Nomenclature

EDS – energy dispersive spectrometer HP – hot pressing m-ZrO₂ – monoclinic zirconium dioxide SEM – scanning electron microscope SHS – self-propagating high-temperature synthesis t-ZrO₂ – tetragonal zirconium dioxide XRD – X-ray diffraction analysis

1. Introduction

The need for new materials is one of the key problems arising in the development of thermal protection systems for airframes and flow paths of propulsion systems of atmospheric high-speed aircraft and reusable aerospace vehicles [1-4]. Ultra-high-temperature ceramics based on ultra-high-melting transition metal borides of Zr(Hf)B₂-SiC [3, 4], Zr(Hf)B₂-SiC-MeSi₂ [5-8], Zr(Hf)B₂-MeSi₂ [9-12] systems and others, where Me is Mo, Zr, Ta, W are promising for structural applications. In this work, the system chosen for research is the ZrSi₂-MoSi₂-ZrB₂ system based on the relatively low melting phase ZrSi₂ ($T_m = 1620^{\circ}$ C) in comparison with MoSi₂ ($T_m = 2020^{\circ}$ C) and ZrB₂ ($T_m = 3245^{\circ}$ C). The interest in these materials is caused by the possibility of their use in slip-firing technologies for modifying matrix of carbon-containing composites and for obtaining protective coatings. This is due to

their ability to form during the heat treatment a significant amount of the liquid phase, necessary for impregnation of the matrix of composites and sintering of the applied powder layers into compact coatings. From these positions, materials based on Zr(Hf)B₂ are unsuitable for application.

The aim of the work was to study the kinetics and mechanism of oxidation of ceramics in the ZrSi₂-MoSi₂-ZrB₂ system at temperatures of 1400 and 1650°C to determine the protective ability of materials and to evaluate the prospects for their further use as heat-resistant compositions.

2. Materials and Investigation Methods

ZrSi₂-MoSi₂-ZrB₂ composite powders were obtained by self-propagating high-temperature synthesis (SHS) including the magnesiothermal recovery stage [13]. Zirconium oxide (ZrO₂) powders, (SiO₂) silicon and molybdenum (MoO₃) of AR grade and boric anhydride (B₂O₃) including base material not less than 99 % were used as the starting components for sample preparation. MPF-3 magnesium powder (Mg) is a reducing agent including 98.5-99.5 % of active component. The preparation of reactor feed (furnace-charge) was carried out in a ball mill with tight-head drums and milling bodies in the form of cylinders of hard metal alloy WC-6 % Co. The ratio of the furnace-charge masses and milling bodies was 1:6. The experimental compositions of the charge were selected to provide after the reduction the varying of concentrations of Zr, Si, Mo, B in the intervals of mass. %: 42.3-66.2; 20.7-40.5; 4.2-14.9 and 2.1-9.2, respectively. Methods of regression analysis and numeric optimization were used to increase efficiency and shorten the duration of investigations in field of searching for chemical compositions of highly refractory materials. The experimental planning matrix was composed so that the investigated concentration points were evenly distributed in the field of interest in Si-Zr-Mo-B phase diagram.

The synthesis was carried out in a universal SHS-8 reactor [14] with 8 liters volume of the reaction chamber with the excessive argon pressure of 3 MPa. The raw materials were loaded to the graphite box by free pouring and then the box was placed into the reaction chamber. To start the combustion process, a tungsten spiral was used. Product cooling was carried out in water cooled reactor tube.

The milling of synthesis products was carried out in two stages: initially coarse fraction of particle size up to 3 mm was obtained through milling in a jaw-breaker, and further milling was carried out using the ball mill. The obtained milling powders represent the designed product mixture – composite powder of the $ZrSi_2$ -MoSi_2-ZrB_2 system with magnesium oxide and unreacted magnesium. To separate the target product, chemical (acidic) enrichment in hydrochloric acid (HCI) water solution was used with heating in a water bath up to 40-50°C for 2 h. Then, the obtained mother liquor was decanted and the separated residue of the target product was filtered and washed with water. Further powder drying was carried out in a SSHVA-2.5-200 drying stove at the temperature of ~ 100°C. Dried powder was milled in the ball mill and classified using a PE-6800. Composite powder fraction with the particle size < 63 µm was subjected to extra milling in a planetary centrifugal mill of MPP-1.

The compact specimen was received by hot-pressing (HP) of the synthesized powders in the DSP-515 SA instrument (Dr. Fritsch, Germany) in vacuum at 1200-1250°C, heating rate of 50 °C/min, pressure of 30 MPa and 10 min isobaric storage. The compacts were obtained as discs with the diameter of 50 mm and width of 5 mm. Samples for investigations were then cut as square layers with the dimensions of $10 \times 10 \times 5$ mm using an EDM machine ARTA 200-2.

Oxidation of samples was carried out in chamber electrical furnaces with a volume of working place of 4 liters at air at temperatures of 1400 and 1650°C by thermo cycling by different schemes. For each composition, 3-4 samples were tested. The oxidation degree was evaluated by the specific weight of samples. Weighing was carried out on an analytical balance AND GR-202 with an accuracy of 10^{-4} g.

Oxidation at 1400°C was performed in a TK.4.1400.1F furnace with SiC heaters. Corundum crucibles with samples were loaded into a furnace preheated to 1400°C, then isothermal exposure was carried out for a specified time, after which the samples were cooled in air at room temperature. Weighing was performed together with crucibles up to 1 hour of total isothermal oxidation every 15 minutes, then up to 2 hours every 30 minutes, then up to 5 hours every 60 minutes, and then up to 10 hours every 150 minutes.

Oxidation at 1650°C was carried out in a Nabertherm LHT 04/17 SW furnace with $MoSi_2$ based heaters. Samples in corundum crucibles were loaded into the furnace at a chamber temperature of

20°C, then heated to 1650°C at a heating rate of 40 °C/min, isothermally kept for a specified time, cooled with the furnace to 20°C, removed from the furnace and weighed. The first two thermal cycles were performed with an isothermal holding of 30 min, the rest 60 min each. The total isothermal holding time at 1650°C was 5 h.

The phase composition was determined by X-ray diffraction analysis (XRD) on an ARL X'tra diffractometer from Thermo Scientific. Microstructural studies were performed using Hitachi S-3400N and Carl Zeiss EVO-40 scanning electron microscopes (SEM) equipped with NORAN System and X-Max Oxford Instruments X-ray energy dispersive spectrometers (EDS), respectively. The samples were manufactured on high-precision equipment from Struers. After the oxidation of the samples, carbon films 50-100 nm thick were deposited on their surface on the vacuum universal post VUP-4 to ensure the flow of electric charge transported to the dielectric surface by a scanning electron beam.

3. Results of research and discussion

3.1. The composition and structure of ceramics in the ZrSi₂-MoSi₂-ZrB₂ system

Compact samples for research were obtained from the 16 composite powder materials synthesized in the ZrSi₂-MoSi₂-ZrB₂ system with different phase ratios. According to XRD data, the main phases in the composition of the samples are ZrSi₂, MoSi₂ and ZrB₂. In addition to these compounds, zircon (zirconium orthosilicate) ZrSiO₄ is present in all samples. In some samples, the m-ZrO₂ phase and crystalline silicon were also detected. Table 1 selectively presents the results of X-ray diffraction, data on hydrostatic ρ_{hydr} and true ρ_{true} density, as well as the values of residual porosity P_{res} of the compact HP-samples.

| Composition | | Phase of | compos | sitior | n, mass. ^o | ρ hydr , | ρtrue, | D 0/2 | | | |
|-------------|-------------------|-------------------|------------------|--------|-----------------------|------------------------|-------------------|-------------------|------------------|--|--|
| | ZrSi ₂ | MoSi ₂ | ZrB ₂ | Si | ZrSiO ₄ | m-ZrO ₂ | g/cm ³ | g/cm ³ | P res, 70 | | |
| 1 | 42 | 22 | 13 | 3 | 20 | - | 4.8 | 4.9 | 2.9 | | |
| 2 | 48 | 13 | 33 | I | 6 | - | 4.6 | 4.8 | 2.5 | | |
| 3 | 22 | 14 | 47 | I | 9 | 8 | 5.3 | 5.5 | 3.5 | | |

Table 1. Phase composition, density and residual porosity of the original compacts

The results of structural studies (according to SEM and EDS) showed that in all samples the matrix is zirconium disilicide ZrSi₂. ZrB₂ particles in the form of elongated crystals of regular cut and MoSi₂ grains are relatively uniformly distributed inside the matrix. The inclusions corresponding to the ZrSiO₄ phase are located at the grain boundaries of the matrix phase. These results of microstructural studies are in good agreement with the XRD data. In addition, all samples revealed oxide inclusions that contain elements of Mg-Si-O in a ratio close to 1:1:2. In some samples, inclusions with elemental composition corresponding to pure Si are also found. The Mg-Si-O inclusions, as well as elemental silicon and ZrSiO₄, are distributed along the boundaries of the ZrSi₂ and MoSi₂ silicides. Since the presence of magnesium silicates was not detected by XRD, it can be assumed that this is due to their X-ray amorphous state.

3.2. Kinetics and mechanism of ceramics oxidation at 1400°C

The kinetic curves of oxidation of compacts at 1400°C are presented in Fig. 1*a* in the form of dependences of the specific weight gain per unit surface area of the samples *q* on the test time *t*. Here the experimental data are shown by the markers, and the solid curves show the results of their approximation using the power dependence $q^n = k \cdot t$, where *k* is the oxidation process constant; *n* is an indicator of a power law. The values of the parameters *k*, n obtained by approximation of the experimental data are presented in Table 2. The experimental data of specific weight gains q_{Σ} of compacts after 10 hours of isothermal exposure at 1400°C is also presented there. It can be seen that the kinetics of oxidation of samples of all compositions is described by a power law with an exponent n > 2, which indicates evolutionary processes in the structure of the forming oxide films. Figure 1*b* shows the time variation of the oxidation rates of the samples. It is seen that at the initial moment of oxidation, the rates are maximum, however, due to the rapid formation of heat-resistant films, their values rapidly decrease (stage I). Subsequently, the oxidation rates continue to monotonously decrease (stage II) due to the continuous inhibition of the diffusion of the reactants through the growing oxide layer and their values almost reach the plateau. The boundary between the marked stages of oxidation is rather arbitrary and does not have an unambiguous definition. As a

boundary criterion separating the indicated steps, we, by analogy with the half-life of quantummechanical systems, chose time $t_{1/2}$, during which the specific weight of the samples would be $\frac{1}{2}$ of their total gain q_{Σ} for the entire oxidation time. The calculated values of these times are given in Table 2 and for clarity, marked with markers in Fig. 1*b*. Table 2 also presents the calculated values of the average oxidation rates of v_{av} of the samples at each of the indicted stages.



Fig. 1. Kinetic curves of oxidation of ceramic samples of compositions *1-3* at 1400°C (*a*) and the corresponding oxidation rates (*b*)

| Composition | <i>q</i> ₅, mg/cm² | k | п | <i>t</i> _{1/2} , min | <i>v_{av}</i> , mg/(c | cm²∙min) | Thickness of oxide layer, µm | | | | |
|-------------|-----------------------|-------|-------|----------------------------------|-------------------------------|------------------------|------------------------------|----------|-----------|--|--|
| | | | | | stage I | stage II | surface / Mg saturated | sublayer | h₂ | | |
| 1 | 3.770 | 0.037 | 2.372 | 115.9 | 0.016 | 3.826·10 ⁻³ | 12-17 / 6-9 | 14-18 | 30- 35 | | |
| 2 | 8.393 | 0.3 | 2.445 | 110.2 | 0.038 | 8.533·10 ⁻³ | 8-11 / 8-11 | 40-45 | 50- 55 | | |
| 3 | 3.435 | 0.583 | 4.928 | 19.7 | 0.083 | 2.828·10 ⁻³ | 8-12 / 5-7 | 45-50 | 55- 60 | | |

Table 2. Characteristics of the kinetics of oxidation of compacts at 1400°C and thickness (h_{Σ}) of the formed oxide layers after 10 hours of isothermal exposure

Typical results of structural studies of cross sections of samples using SEM and EDS after their 10hour oxidation at 1400°C are presented in Fig. 2 in the form of images of microstructures in secondary electrons and corresponding X-ray maps of the distribution of elements.

A common feature for all samples is the formation of a two-layer oxide film in the process of their oxidation, represented by (i) a surface layer based on SiO₂, MgSiO₃ and Mg₂SiO₄, and a sublayer (ii) based on ZrSiO₄ and ZrO₂. It is established that magnesium, initially uniformly distributed in the volume of the initial compacts, is concentrated in the surface layer (i) in the form of MgSiO₃ during the oxidation process. The formation of a continuous vitreous film (i) on the surface of the samples with the presence of individual dispersed ZrSiO₄ particles indicates the migration of a significant part of magnesium silicate and SiO₂ from the sublayer. The absence of boron oxide or borates in the composition of oxidation products on the surface indicates that phases that do not contain boron, i.e. $ZrSi_2$ and MoSi₂ are oxidized preferably. The composition, thickness, and morphology of the oxidation products for compacts 1-3 differ significantly (especially in the near-surface zone). Summary data on the thickness of the formed oxide layers are presented in Table 2.

According to XRD data, the main phases in the composition of the surface layers of the samples are MgSiO₃, Mg₂SiO₄ and SiO₂. Since the thickness of the surface layer for all samples is less than the depth of penetration of X-rays, which, according to our estimates, is 15-20 μ m, the X-ray diffraction data from the surface of the samples also contains information about the phase composition of the upper part of their oxide sublayer. This is evidenced by the ZrSiO₄ phase recorded in all samples. After grinding the surface oxide layer to a depth of ~ 20 μ m, the underlying oxide layers of the samples are represented by the ZrSiO₄ and m-ZrO₂ phases. It should not be excluded that X-ray amorphous silica which cannot be registered by XRD is present in the composition of oxidation products. The presence in the sublayer of composition 3 of a significant amount of the MoSi₂ and ZrB₂ initial phases in the absence of ZrSi₂ indicates preferential oxidation in the matrix phase of ZrSi₂.





Analysis of the obtained results allows us to propose the following mechanism for the oxidation of ceramics of the $ZrSi_2$ -MoSi_2-ZrB_2 system. At a temperature of 1400°C, the surface is passivated, preventing the spreading of active oxidation into the depth of compacts. Component oxidation processes are described by the reactions:

$$ZrSi_{2(s)} + 3O_{2(g)} \rightarrow ZrO_{2(s)} + 2SiO_{2(s)} (\Delta G_{1400^{\circ}C} = -1858.4 \text{ kJ/mol});$$
(1)

$$5MoSi_{2(s)} + 7O_{2(g)} \rightarrow 7SiO_{2(s)} + Mo_5Si_{3(s)} (\Delta G_{1400^{\circ}C} = -3999.9 \text{ kJ/mol});$$
(2)

$$2ZrB_{2(s)} + 5O_{2(g)} \rightarrow 2ZrO_{2(s)} + 2B_2O_{3(h)} (\Delta G_{1400^{\circ}C} = -2740.7 \text{ kJ/mol});$$
(3)

and are accompanied by the interaction of oxidation products:

$$x SiO_{2(s)} + y B_2O_{3(h)} \rightarrow x SiO_2 \cdot y B_2O_{3(s,h)} (\Delta G_{1400^{\circ}C} < 0 \text{ kJ/mol});$$
(4)

$$ZrO_{2(s)} + SiO_{2(s)} \rightarrow ZrSiO_{4(s)} (\Delta G_{1400^{\circ}C} = -2.2 \text{ kJ/mol}).$$
(5)

Obviously, in terms of 1 mol of the starting materials, the oxidation of $ZrSi_2$ according to reaction (1) is more thermodynamically preferably than the oxidation of $MoSi_2$ and ZrB_2 according to reactions (2) and (3). Our studies have shown that from the kinetic point of view, the oxidation of $ZrSi_2$ in heterophase materials of the $ZrSi_2$ - $MoSi_2$ - ZrB_2 system occurs much faster than $MoSi_2$ and ZrB_2 , as evidenced by the predominant oxidation of the samples in the $ZrSi_2$ matrix phase. One of the possible reasons is the selective oxidation of zirconium in $ZrSi_2$, leading to the formation of a heterogeneous film containing, in addition to amorphous SiO_2 , a significant amount of crystalline zirconium dioxide ZrO_2 with high ionic conductivity of oxygen. The oxygen permeability of ZrO_2 contributes to the relatively rapid spread of oxidation into the depths, especially at the initial stage, until the formation of a continuous vitreous layer providing an effective barrier to the diffusion of oxygen. On the contrary, the selective oxidation of silicon in $MoSi_2$ leads to the formation of a heat-resistant SiO_2 film, enveloping the $MoSi_2$ grains and protecting them from further oxidation. ZrB_2 particles are also

susceptible to oxidation mainly at the initial stage, before the formation glass phase which encapsulates them.

The interaction of the primary oxidation products with each other, limited by the rate of diffusion mass transfer of reagents in a complex heterogeneous system, leads to the formation of: (i) a borosilicate glass phase with a single anionic matrix according to reaction (4); (ii) a new crystalline phase of ZrSiO₄ by reaction (5). In the present work, the distribution of boron in glass was not quantified because of the low sensitivity of the EDS to light elements, especially with a low content (in the reaction (4) $\gamma << x$). The formation of zircon ZrSiO₄ is a solid-phase reaction. It should be noted that zircon has a scheelite type structure, which is characterized by a high packing density of atoms in the crystal lattice. This leads to a decrease in the diffusion of oxygen through ZrSiO₄ and increases the heat resistance of materials in the structure of which this phase is present or formed during operation.

In the process of oxidation, a two-layer oxide film is formed, which is represented by (i) a surface layer of silicate glass with $ZrSiO_4$ particles separately located in it and (ii) a sublayer based on $ZrSiO_4$ and ZrO_2 . The main driving force for the growth of the outer vitreous layer is the transport to the surface of viscous-flowing SiO₂, which is formed mainly by reaction (1), due to the volume expansion resulting from the oxidation of $ZrSi_2$. Assuming that the oxidation products have a theoretical density, 1 unit of volume of $ZrSi_2$ gives 0.67 units of volume of t- ZrO_2 and 1.5 units of volume of SiO₂. The volume increase during oxidation compared with the initial $ZrSi_2$ phase is 117 %. The formation of borosilicate glass according to reaction (4) lowers the glass transition temperature in comparison with silica, improves viscous-flow properties and facilitates transport of the glass phase to the surface. Other possible driving forces of the upwelling of SiO₂, such as a temperature gradient and a chemical potential gradient, are unlikely: oxidation at 1400°C was carried out in isothermal conditions, and the concentration of SiO₂ in the inner part of the oxide zone is lower than in the outer.

Simultaneously with the formation of a continuous outer oxide layer, segregation of magnesium initially evenly distributed in the volume of the original compacts, occurs in its outer part, apparently due to the high diffusion rate in the structural components, which at 1400°C are in a viscous-plastic state. Magnesium segregation is associated, on the one hand, with its surface activity with respect to silicon and zirconium, characterized by a lower surface tension value. On the other hand, magnesium has a higher reactivity when interacting with oxygen than zirconium, silicon and boron, as evidenced by the comparative data of the difference in relative electronegativity values according to L. K. Pauling between oxygen and these elements. In our opinion, the formation of an outer layer of glass with a high content of magnesium metasilicate MgSiO₃ helps to reduce the glass transition temperature and viscosity (in comparison with silica), increases the wetting properties of the film, which generally improves the ability of the glass phase to heal defects.

3.3. Kinetics and mechanism of ceramics oxidation at 1650°C

The kinetic curves of oxidation of compacts at 1650°C are presented in Fig. 3*a* in the form of dependences of the specific weight per unit surface area of the samples *q* on the test time *t*. Fig. 3*b* shows the time variation of the oxidation rates of the samples. The values of the kinetic parameters *k*, *n* obtained by approximating the experimental data are given in Table 3 together with experimental data on specific weight gains of samples q_{30} and q_{Σ} after 30 min and 5 hours of isothermal exposure at 1650°C, respectively. It also presents the calculated values of the average oxidation rates of v_{av} of the samples at stages I and II, as well as the values of the transition times $t_{1/2}$.





| Composition | q 30, | <i>q</i> Σ, | k | п | <i>t</i> 1/2, | <i>v_{av},</i> mg/(cm ² ⋅min) | | | |
|-------------|--------------------|--------------------|---------|-------|---------------|--|----------|--|--|
| | mg/cm ² | mg/cm ² | | | min | stage I | stage II | | |
| 1 | 19.234 | 41.798 | 49.525 | 2.579 | 50.2 | 0.413 | 0.083 | | |
| 2 | 12.892 | 36.861 | 3.008 | 1.887 | 81.1 | 0.227 | 0.084 | | |
| 3 | 18.849 | 33.636 | 468.692 | 3.383 | 28.8 | 0.578 | 0.061 | | |

Table 3. Characteristics of the kinetics of oxidation of compacts at 1650°C after total isothermal exposure for 5 hours

Typical structures of cross sections of samples after their 5-hour oxidation are shown in Fig. 4 in the form of images of microstructures in secondary electrons, separate X-ray maps of the distribution of elements and multi-layer combined images created on the basis of the combination of electronic images and X-ray maps. The formed oxide films have a complex heterogeneous structure and a multilayer structure. Summary data on the thickness of the forming layers are presented in Table 4.

Table 4. Thickness of the formed oxide layers after isothermal exposure of compacts at 1650°C for30 min and 5 hours

| | Thickness of the | oxide layer | after | Thickness of the oxide layer after isothermal | | | | | |
|-------------|-------------------|-----------------------|--------|---|---------------------|---------------------|---------------------|------|--|
| Composition | isothermal exposu | <u>re for 30 m</u> | in, µm | exposure for 5 h, μm | | | | | |
| | surfaco / Ma | sublayer | h₂ | surface / Mg | | | | | |
| | surface / Mg | (based | | | based | based | based | h₂ | |
| | Saturateu | on ZrO ₂) | | Saturateu | on SiO ₂ | on ZrO ₂ | on SiO ₂ | | |
| 1 | 5-7 / 3-5 | 220-230 | 225- | 4-6 / 4-6 | 90- | 160- | 260- | 515- | |
| | | | 240 | | 100 | 170 | 270 | 535 | |
| 2 | E 7 / 2 E | 155-170 | 160- | 10 20 / 4 6 | _ | 170- | 150- | 340- | |
| | 5-6 / 7-5 | | 180 | 10-20 / 4-0 | | 180 | 160 | 360 | |
| 3 | 12 17 / 0 12 | 220 240 | 335- | 15 20 / 15 20 | 130- | 390- | | 550- | |
| | 12-17 / 9-12 | 520-340 | 355 | 15-20 / 15-20 | 140 | 410 | _ | 570 | |

A distinctive feature of experiments on the oxidation of HP samples of the ZrSi₂-MoSi₂-ZrB₂ system with isothermal exposure at a temperature of 1650°C is the presence of low-temperature stages associated with heating and cooling of compacts with a furnace. Therefore, the results obtained integrally reflect the behavior of samples during thermal cycling in the range of 20-1650°C, including conditions (~ 750-1250°C), when the protective properties of oxide films cannot be fully realized.

It is assumed that the dominant chemical process is the oxidation of $ZrSi_2$ by reaction (1). The melting of $ZrSi_2$ in the peritectic reaction, starting at a temperature of 1620°C, causes the appearance of a liquid silicon phase. The liquid phase provides faster mass transfer of reagents [2, 9], which additionally accelerates the oxidation process. Also, the oxidation of MoSi₂, ZrB_2 phases takes place according to reactions (2), (3) and the formation of borosilicate glass by reaction (4). The calculated values of the isobaric-isothermal potential ΔG at 1650°C for reactions (1) - (4) are, respectively, kJ/mol: -1733.2; -3714.7; -2562.8; < 0 (specific value depends on the ratio of the coefficients *x* and *y*).

The formation of the zircon phase by reaction (5) according to thermodynamic calculations is possible at temperatures of up to ~ 1539°C, at which ΔG changes its sign from negative to positive. With increasing temperature, reaction (5) goes in the opposite direction, i.e. thermal dissociation of ZrSiO₄ to the initial oxide components SiO₂ and ZrO₂ is observed. The results of the structural-phase studies performed by us on the ZrSi₂-MoSi₂-ZrB₂ system after oxidation showed that the proportion of the ZrSiO₄ phase in the structure of the oxide layers is low. At the same time, the detected particles are surrounded by SiO₂ silica. It is probably that the presence of an external SiO₂ shell enveloping the ZrSiO₄ phase shifts the chemical equilibrium of reaction (5) towards the formation of the final product, i.e. raises the dissociation temperature of ZrSiO₄.

In the process of oxidation and dissociation, a multilayer oxide film is formed, which is represented by (i) a surface layer of silicate glass with separately located ZrSiO₄ particles (ii) ZrO₂ and SiO₂ based sublayers. A part of silicon dioxide SiO₂, formed during the oxidation of ZrSi₂, MoSi₂ and dissociation of ZrSiO₄, remains in the bulk of the oxide film and fills the pores that are not occupied by ZrO₂. The other part is transferred to the surface, ensuring the formation of a continuous vitreous layer. Upwelling, as well as at 1400°C, is driven by volume expansion during oxidation. The formation of borosilicate glass according to reaction (4) reduces the viscosity of the melt and facilitates its

transport to the surface. At the same time, magnesium is segregated in the outer part of the outer oxide layer in the same way as described in section 3.2. It should be noted that the observed thickness of the surface glass layer after oxidation at 1650°C seems to be thinner than the thickness of the layer formed at less high temperatures, due to possible partial evaporation of the silicate glass.



Fig. 4. Microstructure (*a*, *c*) and distribution of elements in characteristic X-rays (*b*, *d*) in samples after isothermal oxidation at 1650°C, 5 hours: composition 1 - a, *b*, composition 2 - c, *d*

A characteristic feature of the oxidation of compositions 1 and 2 at 1650°C is the formation in the upper part of their subsurface oxide layer of the secondary phases Mo₅Si₃ and MoB according to reactions (2) and (6), where B₂O₃ in (6) is the oxidation product of ZrB₂ by reaction (3):

$$HOSi_{2(s)} + 2B_2O_{3(t)} + 5O_{2(g)} \rightarrow 8SiO_{2(s)} + 4MoB_{(s)} (\Delta G_{1650^{\circ}C} = -2828.2 \text{ kJ/mol}).$$
(6)

The decrease in the partial pressure of oxygen over the thickness of the oxide film together with the encapsulation of ZrB_2 particles in the silicate matrix explains the impossibility of carrying out the reaction (6) in the deep oxide layers. The resulting Mo₅Si₃ and MoB phases are highly heat-resistant [9] and refractory (their melting points are 2180 and 2600°C, respectively). Interestingly, after oxidation of ceramics of composition $85ZrB_2$ -15MoSi₂ (vol. %) At 1650°C for 15 min, the authors of [9] found the presence of an interlayer in the oxide zone consisting of MoB particles tightly adjacent to each other. According to the results of our studies, after oxidation of ceramics of the ZrSi₂-MoSi₂-ZrB₂ system at 20-1650°C with an exposure at a maximum temperature of 5 hours, the MoB segregations is represented by individual particles located at a considerable distance from each other. These differences should be attributed to the dominant role of the liquid-phase oxidation of ZrSi₂, as a result of which the resulting glass phase envelops the ZrB₂ and MoSi₂ particles, limiting the access of oxygen required for reactions (3) and (6). The absence of MoB particles in the oxide zone of composition *3* is obviously due to the high degree of distribution of the glass phase between the structural components, which leads to a more complete encapsulation of ZrB₂ and MoSi₂ particles.

The coefficients in the regression equations are calculated by the Levenberg-Marquardt algorithm using the least squares method. The calculations were performed in a mathematical package of the

MathCAD software product. Analysis of the constructed response surfaces in the form of diagrams "phase composition - heat resistance" made it possible to establish that an increase in the content of ZrB_2 and $MoSi_2$ phases in the structure of ceramics leads to an increase in their heat resistance at 1650°C, and the $ZrSi_2$ phase together with $ZrSiO_4$ - on the contrary, to decrease (Fig. 5).



Fig. 5. Calculated diagram "phase composition - heat resistance" for ceramics of $ZrSi_2$ -MoSi_2-ZrB₂ system at 1650°C: MoSi_2 = 7 mass. % (*a*), MoSi_2 = 17 mass. % (*b*)

A physicochemical interaction in the $ZrSi_2$ - $ZrSiO_4$ system, not previously described in the literature, was found, resulting in the reduction of elemental silicon with simultaneous oxidation of zirconium to a thermodynamically stable ZrO_2 phase. In conditions of lack or absence of oxygen, the interaction at temperatures above 1620°C is described by the following equation (7):

$$ZrSi_{2(h)} + ZrSiO_{4(s)} = 2ZrO_{2(s)} + 3Si_{(h)}.$$
 (7)

The reaction proceeds with an increase in the volume of products, which leads to an increase in the internal pressure in the samples, under the action of which (together with capillary forces) silicon and/or eutectics (Si + $ZrSi_2$) exit to the outside. This explains the appearance of blisters, fistulas and sweating droplets on the surface of the samples.

4. Conclusions

1. Ceramic materials in the $ZrSi_2$ -MoSi_2-ZrB_2 system were produced by a combination of SHS technologies and hot pressing.

2. The kinetics and mechanism of high-temperature oxidation of ceramics was studied at temperatures of 1400 and 1650°C for 10 and 5 hours, respectively. The influence of the $ZrSi_2$, $MoSi_2$ and ZrB_2 phases on the structural-morphological features of the formation of oxide films and the effectiveness of their protective action was analyzed.

3. During oxidation at 1400°C, a two-layer structure is formed. It consists of a continuous silicate film, the outer part of which is saturated with magnesium, and a sublayer based on the $ZrSiO_4$ phase with a scheelite structure encapsulating ZrB_2 and $MoSi_2$ grains.

4. During oxidation at 1650°C, a multilayer structure is formed. It consists of a layer of complex silicate glass and sublayers based on ZrO_2 and SiO_2 . Partial dissociation of $ZrSiO_4$ and the formation of MoB and Mo_5Si_3 secondary phases are noted. Above 1620°C under conditions of oxygen deficiency in the $ZrSi_2$ - $ZrSiO_4$ system, the reduction of silicon with simultaneous oxidation of zirconium to the thermodynamically stable ZrO_2 phase was established.

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